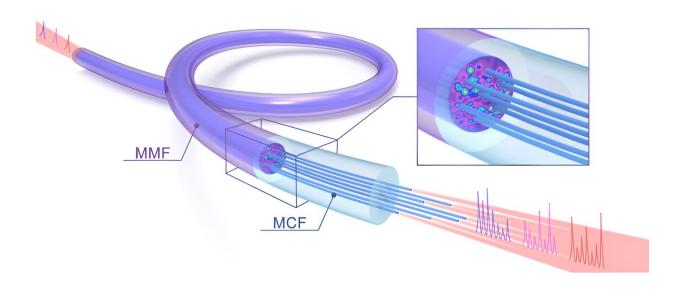


Researchers develop ultrafast wavemeter that employs spectral-spatial-temporal mapping

May 30 2024



the input pulse is mapped into a speckle pattern through the MMF. Then, the MCF samples the output pattern into a pulse sequence. The seven cores of the MCF are extended in different lengths to avoid overlapping. Credit: Zheng Gao, Ting Jiang, Mingming Zhang, Yuxuan Xiong, Hao Wu, and Ming Tang.

Accurate high-speed measurements of wavelength are fundamental to optical research and industrial applications, such as environmental monitoring, biomedical analysis, and material characterization.

Recent studies have shown that a disordered scattering medium such as a multimode fiber can generate a wavelength-dependent <u>speckle</u> pattern,



which can provide a high spectral resolution and broad operational bandwidth in a compact structure. However, the measurement speeds of current speckle spectrometers are constrained by cameras, which limits their applications.

In a new paper <u>published</u> in *Light: Advanced Manufacturing*, a team of scientists, led by Professor Ming Tang and Dr. Hao Wu from Huazhong University of Science and Technology, China, with doctoral students Zheng Gao and Ting Jiang as co-first authors, have developed an ultrafast wavemeter based on multimode and multicore fibers, which employs spectral–spatial–temporal mapping.

By integrating the speckle pattern characteristics of multimode fibers with the sampling capabilities of multicore fibers, this new method achieves a spectral measurement speed of 100MHz without compromising accuracy.

The scientists summarize the operational principle of their wavemeter, saying, "To break through this speed limitation, we introduced multicore fibers, proposing an innovative spectral-space-time mapping scheme. We fused multicore fibers to the output end of multimode fibers, using each core to sample the speckle pattern, effectively transforming the intensity distribution into a pulse signal sequence. As a result, high-speed single-pixel photodetectors replaced traditional cameras, overcoming the frame rate limitations and achieving a leap in measurement speed."

"We experimentally demonstrated a measurement rate of 100 MHz while maintaining a high resolution of 2.7pm. This measurement method has significant potential for application in many fields."

More information: Zheng Gao et al, Breaking the speed limitation of



wavemeter through spectra-space-time mapping, *Light: Advanced Manufacturing* (2024). DOI: 10.37188/lam.2024.013

Provided by Chinese Academy of Sciences

Citation: Researchers develop ultrafast wavemeter that employs spectral–spatial–temporal mapping (2024, May 30) retrieved 18 June 2024 from https://phys.org/news/2024-05-ultrafast-wavemeter-employs-spectralspatialtemporal.html

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